

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,042	AHN ET AL.	
Examiner	Art Unit	
Matthew C. Landau	2815	

SEARCHED				
Class	Subclass	Date	Examiner	
257	.172, .165, E29, 165,	8/28/07	^	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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(INCLUDING SEARC	DATE	EXMR
EAST Search (printout included)	8/28/07	~
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